

TOSHIBA Field Effect Transistor Silicon P Channel MOS Type (U-MOS II)

# **TPCS8101**

Lithium Ion Battery Applications Portable Equipment Applications Notebook PCs

• Small footprint due to small and thin package

• Low drain-source ON resistance:  $RDS(ON) = 15 \text{ m}\Omega$  (typ.)

• High forward transfer admittance:  $|Y_{fs}| = 12 \text{ S (typ.)}$ 

• Low leakage current:  $I_{DSS} = -10 \mu A \text{ (max) (V}_{DS} = -30 \text{ V)}$ 

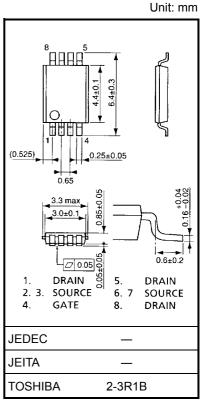
• Enhancement-mode:  $V_{th} = -0.8 \sim -2.0 \text{ V (V}_{DS} = -10 \text{ V, I}_{D} = -1 \text{ mA})$ 

### **Maximum Ratings (Ta = 25°C)**

Characte	ristics	Symbol	Rating	Unit	
Drain-source voltage		$V_{DSS}$	-30	V	
Drain-gate voltage (R	k <sub>GS</sub> = 20 kΩ)	$V_{DGR}$	-30	V	
Gate-source voltage		$V_{GSS}$	±20	V	
Drain current	DC (Note 1)	I <sub>D</sub>	-6	Α	
Diam current	Pulse (Note 1)	$I_{DP}$	-24	A	
Drain power dissipati	on (t = 10 s) (Note 2a)	$P_{D}$	1.5	W	
Drain power dissipati	on (t = 10 s) (Note 2b)	$P_{D}$	0.6	W	
Single pulse avalance	ne energy (Note 3)	E <sub>AS</sub>	46.8	mJ	
Avalanche current		I <sub>AR</sub>	-6	Α	
Repetitive avalanche	energy (Note 2a, Note 4)	E <sub>AR</sub>	0.15	mJ	
Channel temperature		T <sub>ch</sub>	150	°C	
Storage temperature	range	T <sub>stg</sub>	-55 to 150	°C	

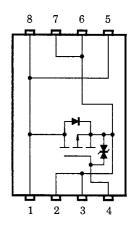
Note: For (Note 1), (Note 2), (Note 3) and (Note 4), please refer to the next page.

This transistor is an electrostatic sensitive device. Please handle with caution.



Weight: 0.035 g (typ.)

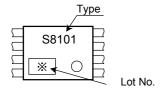
## **Circuit Configuration**



#### **Thermal Characteristics**

Characteristics	Symbol	Max	Unit
Thermal resistance, channel to ambient (t = 10 s) (Note 2a)	R <sub>th (ch-a)</sub>	83.3	°C/W
Thermal resistance, channel to ambient (t = 10 s) (Note 2b)	R <sub>th (ch-a)</sub>	208	°C/W

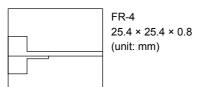
### Marking (Note 5)



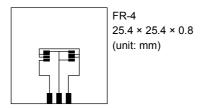
Note 1: Please use devices on condition that the channel temperature is below 150°C.

Note 2:

a) Device mounted on a glass-epoxy board (a)



b) Device mounted on a glass-epoxy board (b)

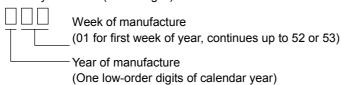


Note 3:  $V_{DD}$  = -24 V,  $T_{ch}$  = 25°C (initial), L = 1.0 mH,  $R_G$  = 25  $\Omega$ ,  $I_{AR}$  = -6.0 A

Note 4: Repetitive rating: pulse width limited by maximum channel temperature

Note 5: O on lower right of the marking indicates Pin 1.

Weekly code: (Three digits)



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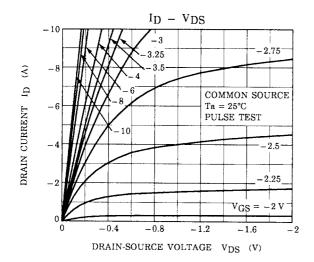
# Electrical Characteristics (Ta = 25°C)

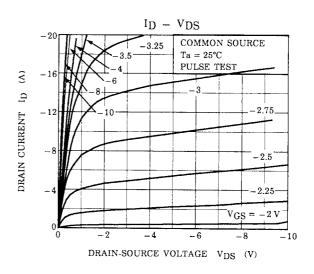
Chara	cteristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Gate leakage curi	rent	I <sub>GSS</sub>	V <sub>GS</sub> = ±16 V, V <sub>DS</sub> = 0 V	_	_	±10	μΑ
Drain cut-OFF cu	rrent	I <sub>DSS</sub>	$V_{DS} = -30 \text{ V}, V_{GS} = 0 \text{ V}$	_	_	-10	μA
Drain-source breakdown voltage		V (BR) DSS	$I_D = -10 \text{ mA}, V_{GS} = 0 \text{ V}$	-30	_		٧
Brain-30dice bice	rain-source breakdown voltage		$I_D = -10 \text{ mA}, V_{GS} = 20 \text{ V}$	-15	—		
Gate threshold vo	ate threshold voltage		$V_{DS} = -10 \text{ V}, I_D = -1 \text{ mA}$	-0.8	—	-2.0	V
Drain source ON	rosistanco	R <sub>DS</sub> (ON)	$V_{GS} = -4 \text{ V}, I_D = -3 \text{ A}$	_	32	40	mΩ
Drain-source ON resistance		R <sub>DS</sub> (ON)	$V_{GS} = -10 \text{ V}, I_D = -3 \text{ A}$	_	15	25	mtz
Forward transfer a	orward transfer admittance		$V_{DS} = -10 \text{ V}, I_D = -3 \text{ A}$	6	12	_	S
Input capacitance		C <sub>iss</sub>		_	1810	_	pF
Reverse transfer capacitance		C <sub>rss</sub>	V <sub>DS</sub> = -10 V, V <sub>GS</sub> = 0 V, f = 1 MHz	_	350	_	pF
Output capacitance		Coss		_	610	_	pF
Switching time	Rise time	t <sub>r</sub>	$V_{GS} = \begin{array}{c} 0 \text{ V} & I_{D} = -3 \text{ A} \\ V_{OUT} & V_{OUT} \\ \downarrow & \downarrow \\ V_{DD} = 5 \Omega \\ V_{DD} = -15 \text{ V} \\ \text{Duty} \leq 1\%, \ t_{W} = 10  \mu\text{s} \\ \end{array}$	_	9	1	
	Turn-ON time	t <sub>on</sub>		_	15	_	ns
	Fall time	t <sub>f</sub>		_	49		113
	Turn-OFF time	t <sub>off</sub>		_	135	_	
Total gate charge (gate-source plus gate-drain)		Qg			37		nC
Gate-source charge		Q <sub>gs</sub>	$V_{DD} \approx -24 \text{ V}, V_{GS} = -10 \text{ V}, I_D = -6 \text{ A}$	_	30	_	nC
Gate-drain ("miller") charge		Q <sub>gd</sub>		_	7		nC

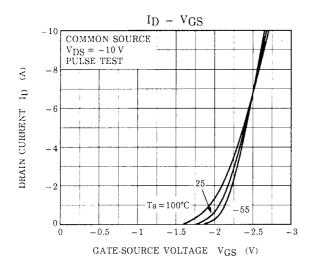
# **Source-Drain Ratings and Characteristics (Ta = 25°C)**

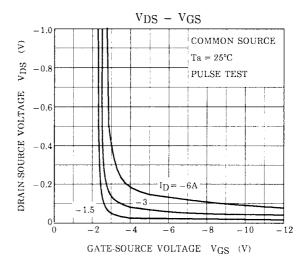
Charact	eristics	Symbol	Test Condition	Min	Тур.	Max	Unit
Drain reverse current	Pulse (Note 1)	I <sub>DRP</sub>	-	_	_	-24	Α
Forward voltage	(diode)	$V_{DSF}$	$I_{DR} = -6 \text{ A}, V_{GS} = 0 \text{ V}$	_	_	1.2	V

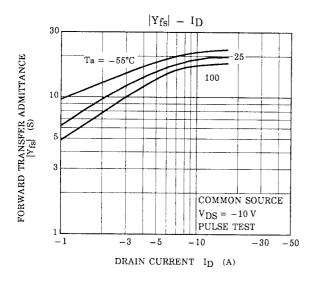
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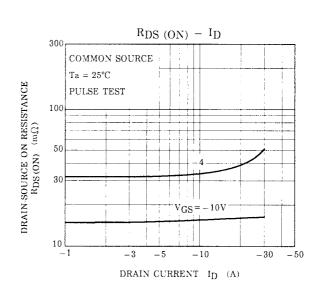




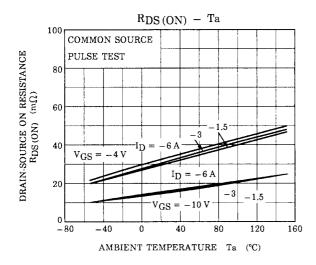


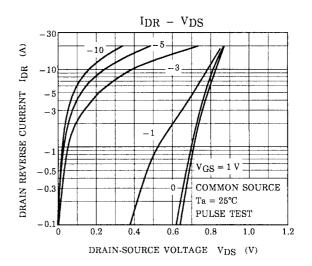


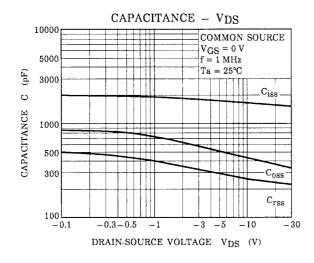


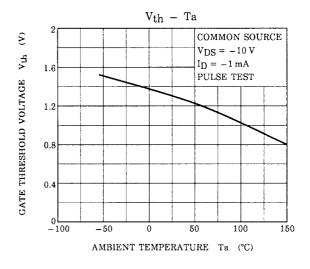


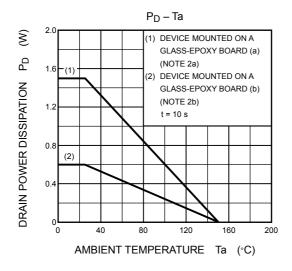
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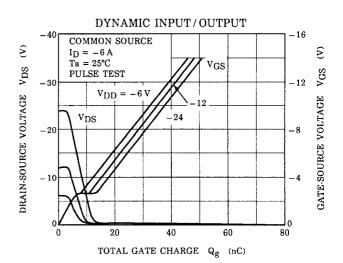




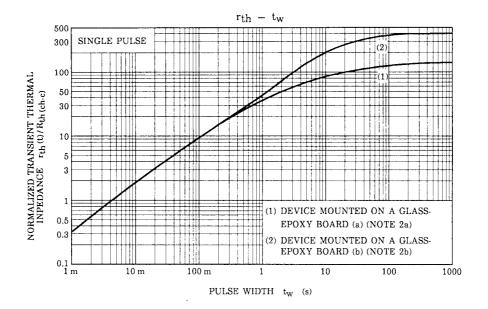


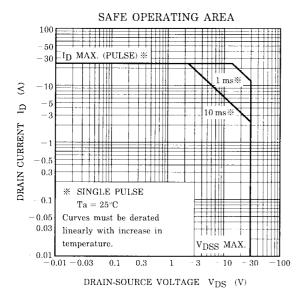


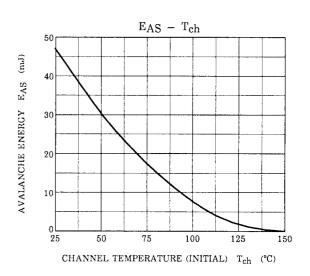


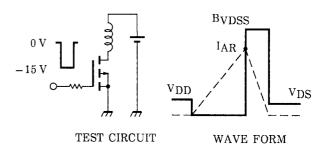


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$$\begin{array}{l} T_{ch}=25^{\circ}C~(Initial)\\ Peak~I_{AR}=-6~A,~R_{G}=25~\Omega~E_{AS}=\frac{1}{2}\cdot L\cdot I^{2}\cdot (\frac{BVDSS}{BVDSS-VDD})\\ V_{DD}=-16~V,~L=1.0~mH \end{array}$$

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